

Search Notes

Application/Control No.

10/516,511

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

OYAMA, KATSUHIKO

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
206	449, 454	2/2/2006	LKB
	710, 711		
	832		
118	500		
141	1, 98		
211	41.18		
	41.17		
414	217, 935		
	936, 940		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
pgpub	text	2/3/2006	LKB
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